

Search Notes

Application/Control No.

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Examiner

Phu Vu

Applicant(s)/Patent under
Reexamination

CHANG ET AL.

Art Unit

2871

SEARCHED

Class	Subclass	Date	Examiner
349	106-109	4/17/2005	P.V.

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR